SCBS040A - JANUARY 1990 - REVISED JANUARY 1994

- BiCMOS Design Significantly Reduces I<sub>CCZ</sub>
- 3-State True Outputs Drive Bus Lines Directly
- High-Impedance State During Power Up and Power Down
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic 300-mil DIPs (N)

# DIR 1 20 VC( A1 2 19 OE

DIR [	1	20	V <sub>CC</sub>
A1 [	2	19	OE
A2 [	3	18	B1
АЗ [	4	17	B2
A4 [	5	16	<b>B</b> 3
A5 [	6	15	] B4
A6 [	7	14	] B5
A7 [	8	13	] B6
A8 [	9	12	] B7
GND [	10	11	] B8

### description

This octal bus transceiver is designed for asynchronous communication between data

buses. The devices transmit data from the A bus to the B bus or from the B bus to the A bus depending upon the logic level at the direction-control (DIR) input. The output-enable  $(\overline{OE})$  input can be used to disable the device so the buses are effectively isolated.

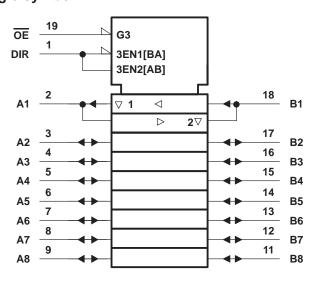
The outputs are in a high-impedance state during power up and power down while the supply voltage is less than approximately 3 V.

The SN64BCT245 is characterized for operation from −40°C to 85°C and 0°C to 70°C.

#### **FUNCTION TABLE**

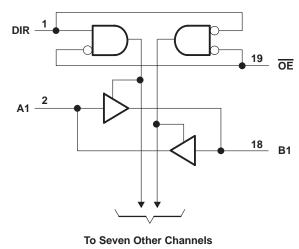
INP	UTS	ODED ATION			
OE	DIR	OPERATION			
L	L	B data to A bus			
L	Н	A data to B bus			
Н	X	Isolation			

# logic symbol†



# † This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

# logic diagram (positive logic)



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# SN64BCT245 OCTAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS

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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	– 0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	– 0.5 V to 7 V
Voltage range applied to any output in the disabled or power-off state, V <sub>O</sub>	– 0.5 V to 5.5 V
Voltage range applied to any output in the high state, V <sub>O</sub>	– 0.5 V to V <sub>CC</sub>
Current into any output in the low state	128 mA
Operating free-air temperature range	– 40°C to 85°C
Storage temperature range	– 65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage		2			V
VIL	Low-level input voltage				8.0	V
ΙK	Input clamp current				-18	mA
	High level autout august	A1-A8			-3	A
IOH	High-level output current	B1-B8			-15	mA
	Law level entert somest	A1-A8			24	A
lOL	Low-level output current	B1-B8			64	mA
TA	Operating free-air temperature		-40		85	°C

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CONDITIONS		MIN	TYP <sup>†</sup>	MAX	UNIT
٧ıK		$V_{CC} = 4.5 V$ ,	I <sub>I</sub> = -18 mA				-1.2	V
	Any A		$I_{OH} = -1 \text{ mA}$		2.5	3.4		
Vон	Any A or B	V <sub>CC</sub> = 4.5 V	$I_{OH} = -3 \text{ mA}$		2.4	3.3		V
	Any B		I <sub>OH</sub> = -15 mA		2	3.1		
.,	Any A	V 45V	I <sub>OL</sub> = 24 mA			0.35	0.5	.,
VOL	Any B	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 64 mA			0.42	0.55	V
	_	V 01 00V	V <sub>O</sub> = 2.7 V	<del></del>			70	μΑ
	Power up	$V_{CC} = 0$ to 2.3 V	V <sub>O</sub> = 0.5 V	OE at 0.8 V			-0.65	mA
loz			V <sub>O</sub> = 2.7 V	<del></del>			70	μΑ
	Power down	$V_{CC} = 1.8 \text{ V to } 0$	V <sub>O</sub> = 0.5 V	OE at 0.8 V			-0.65	mA
. +	A and B	V 55V	V 55V				1	
11‡	DIR and OE	V <sub>CC</sub> = 5.5 V,	$V_O = 2.7 \text{ V}$ $V_O = 0.5 \text{ V}$ $V_O = 2.7 \text{ V}$ OE at				0.1	mA
. +	A and B	V 5.5.V	V 07V				70	•
I <sub>IH</sub> ‡	DIR and OE	V <sub>CC</sub> = 5.5 V,	V <sub>1</sub> = 2.7 V				20	μΑ
	A and B	V 5.5.V	V 05V				-0.65	4
ΊL	DIR and OE	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V				-1.2	mA
8	Any A	V 5.5.V			-60		-150	4
I <sub>OS</sub> §	Any B	V <sub>CC</sub> = 5.5 V,	ΛO = 0		-100		-225	mA
ICCH	A-to-B	V <sub>CC</sub> = 5.5 V				36	57	
ICCL	A-to-B	V <sub>CC</sub> = 5.5 V				57	90	mA
ICCZ		V <sub>CC</sub> = 5.5 V				10	15	
Ci	OE and DIR	V <sub>CC</sub> = 5 V,	V <sub>I</sub> = 2.5 V or 0.5 V			7		pF
C.	A to B	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	V: 05V = 05V			9		»E
C <sub>io</sub>	B to A	V <sub>CC</sub> = 5 V,	$V_I = 2.5 \text{ V or } 0.5 \text{ V}$			12		pF

# switching characteristics (see Note 2)

PARAMETER	FROM	TO	R1 = 5	50 pF, 500 Ω,	R2 = 500 Ω				UNIT
	(INPUT)	(OUTPUT)		R2 = 500 Ω, T <sub>A</sub> = 25°C		-40°C 5°C	T <sub>A</sub> = to 70		
			MIN	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	A D	D or A	1	6	1	7.2	1	7	
t <sub>PHL</sub>	A or B	B or A	1.5	6.6	1.5	7.6	1.5	7	ns
<sup>t</sup> PZH	- OE	A or D	1.5	9.4	1.5	11.2	1.5	10.9	
t <sub>PZL</sub>	OE .	A or B	1.5	10.2	1.5	11.8	1.5	11.6	ns
<sup>t</sup> PHZ	ŌĒ	A or B	1.5	8.3	1.5	9.7	1.5	9.3	ns
t <sub>PLZ</sub>	UE	AUID	1.5	7.8	1.5	9.6	1.5	9.1	115

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. ‡ For I/O ports, the parameters  $I_{IH}$  and  $I_{IL}$  include the off-state output current.

<sup>§</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

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#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN64BCT245DW	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT245	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN64BCT245DW	DW	SOIC	20	25	507	12.83	5080	6.6



SOIC



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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